

Automotive MOSFET

OptiMOS™ 7 Power-Transistor



Features

- OptiMOS™ power MOSFET for automotive applications
- N-channel – Enhancement mode – Logic Level
- Extended qualification beyond AEC-Q101
- Enhanced electrical testing
- Robust design
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- RoHS compliant
- 100% Avalanche tested

Potential Applications

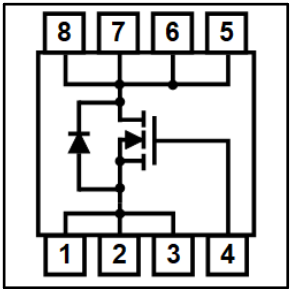
General automotive applications.

Product Validation

Qualified for automotive applications. Product validation according to AEC-Q101.

Product Summary

$V_{DS}$	80	V
$R_{DS(on)}$	1.26	mΩ
$I_D$ (chip limited)	293	A



Type	Package	Marking
IAUCN08S7L013	PG-TDSON-8-53	7N08L013



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## Maximum Ratings

at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	$I_D$	$V_{GS} = 10\text{ V}$ , Chip limitation <sup>1,2)</sup>	293	A
		$V_{GS} = 10\text{ V}$ , DC current	175	
		$T_a = 100^\circ\text{C}$ , $V_{GS} = 10\text{ V}$ , $R_{thJA}$ on 2s2p <sup>2,3)</sup>	32	
Pulsed drain current <sup>2)</sup>	$I_{D,pulse}$	$T_C = 25^\circ\text{C}$ , $t_p = 100\text{ }\mu\text{s}$	954	
Avalanche energy, single pulse <sup>2)</sup>	$E_{AS}$	$I_D = 82\text{ A}$	213	mJ
Avalanche current, single pulse	$I_{AS}$	–	163	A
Gate source voltage	$V_{GS}$	–	$\pm 16$	V
		Limited to duty factor of 1%	+20	
Power dissipation	$P_{tot}$	$T_C = 25^\circ\text{C}$	219	W
Operating and storage temperature	$T_j, T_{stg}$	–	-55 ... +175	$^\circ\text{C}$

## Thermal Characteristics<sup>2)</sup>

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Thermal resistance, junction - case	$R_{thJC}$	–	–	–	0.69	K/W
Thermal resistance, junction - ambient <sup>3)</sup>	$R_{thJA}$	–	–	25.9	–	

## Electrical Characteristics

at  $T_j=25^\circ\text{C}$ , unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

### Static Characteristics

Drain-source breakdown voltage	$V_{(Br)DSS}$	$V_{GS} = 0\text{ V}$ , $I_D = 1\text{ mA}$	80	–	–	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$ , $I_D = 131\text{ }\mu\text{A}$	1.2	1.6	2.0	
Zero gate voltage drain current	$I_{DSS}$	$V_{DS} = 80\text{ V}$ , $V_{GS} = 0\text{ V}$ , $T_j = 25^\circ\text{C}$	–	–	1	$\mu\text{A}$
		$V_{DS} = 80\text{ V}$ , $V_{GS} = 0\text{ V}$ , $T_j = 100^\circ\text{C}^{2)}$	–	–	33	
Gate-source leakage current	$I_{GSS}$	$V_{GS} = 16\text{ V}$ , $V_{DS} = 0\text{ V}$	–	–	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS} = 4.5\text{ V}$ , $I_D = 88\text{ A}$	–	1.34	1.72	m $\Omega$
		$V_{GS} = 10\text{ V}$ , $I_D = 88\text{ A}$	–	1.14	1.26	
Gate resistance <sup>2)</sup>	$R_G$	–	–	2.0	–	$\Omega$

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Dynamic Characteristics <sup>2)</sup>						
Input capacitance	$C_{iss}$	$V_{GS} = 0\text{ V}, V_{DS} = 40\text{ V}, f = 1\text{ MHz}$	–	7349	9554	pF
Output capacitance	$C_{oss}$		–	2842	3695	
Reverse transfer capacitance	$C_{rss}$		–	33	50	
Turn-on delay time	$t_{d(on)}$	$V_{DD} = 40\text{ V}, V_{GS} = 10\text{ V},$ $I_D = 88\text{ A}, R_G = 3.5\text{ }\Omega$	–	15.0	–	ns
Rise time	$t_r$		–	14.0	–	
Turn-off delay time	$t_{d(off)}$		–	102.4	–	
Fall time	$t_f$		–	35.0	–	

<b>Gate Charge Characteristics<sup>2)</sup></b>						
Gate to source charge	$Q_{gs}$	$V_{DD} = 40\text{ V}, I_D = 88\text{ A},$ $V_{GS} = 0\text{ to }10\text{ V}$	–	20.8	27.1	nC
Gate to drain charge	$Q_{gd}$		–	16.7	25.1	
Gate charge total	$Q_g$		–	120.0	156.0	
Gate plateau voltage	$V_{plateau}$		–	2.8	–	V

<b>Reverse Diode</b>						
Diode continuous forward current <sup>2)</sup>	$I_S$	$T_C = 25^\circ\text{C}$	–	–	175	A
Diode pulse current <sup>2)</sup>	$I_{S,pulse}$	$T_C = 25^\circ\text{C}, t_p = 100\ \mu\text{s}$	–	–	954	
Diode forward voltage	$V_{SD}$	$V_{GS} = 0\text{ V}, I_F = 88\text{ A}, T_j = 25^\circ\text{C}$	–	0.9	1.0	V
Reverse recovery time <sup>2)</sup>	$t_{rr}$	$V_R = 40\text{ V}, I_F = 50\text{ A}$ $di_F/dt = 100\text{ A}/\mu\text{s}$	–	44	66	ns
Reverse recovery charge <sup>2)</sup>	$Q_{rr}$		–	32	64	nC

<sup>1)</sup> Practically the current is limited by the overall system design including the customer-specific PCB.

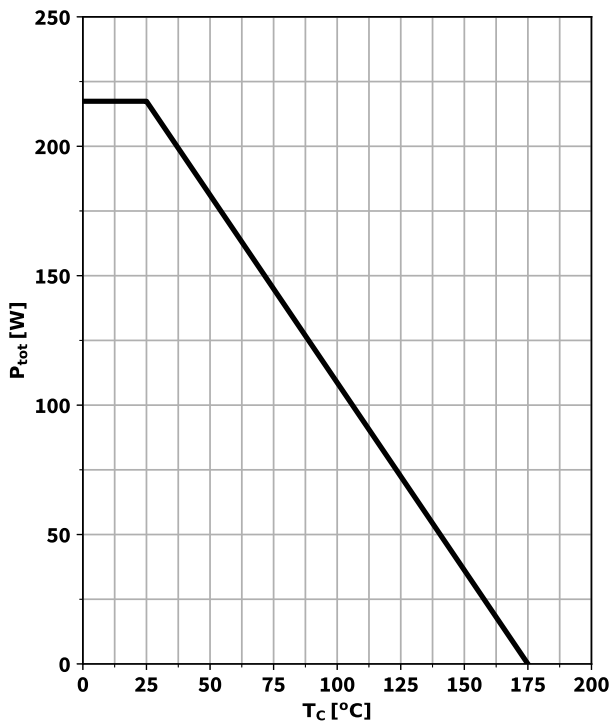
<sup>2)</sup> The parameter is not subject to production testing – specified by design.

<sup>3)</sup> Device on 2s2p FR4 PCB defined in accordance with JEDEC standards (JESD51-5, -7). PCB is vertical in still air.

## Electrical characteristics diagrams

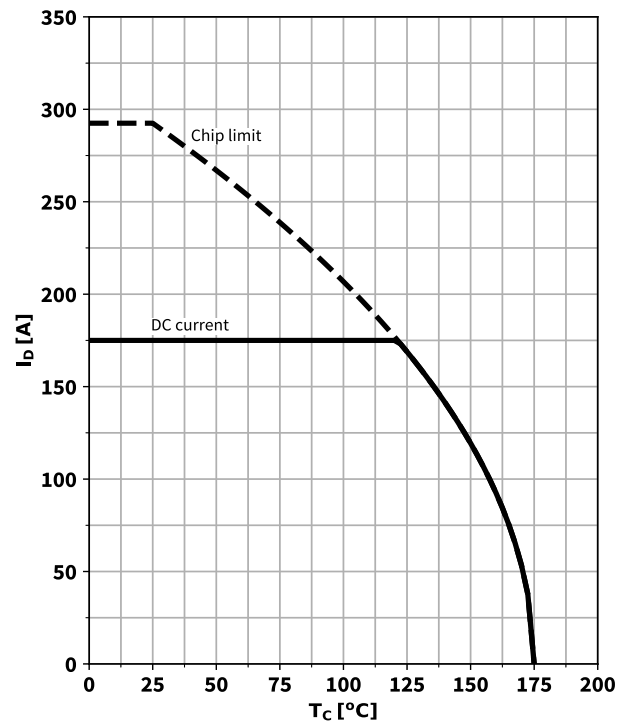
### 1 Power dissipation

$$P_{\text{tot}} = f(T_C); V_{\text{GS}} \geq 6 \text{ V}$$



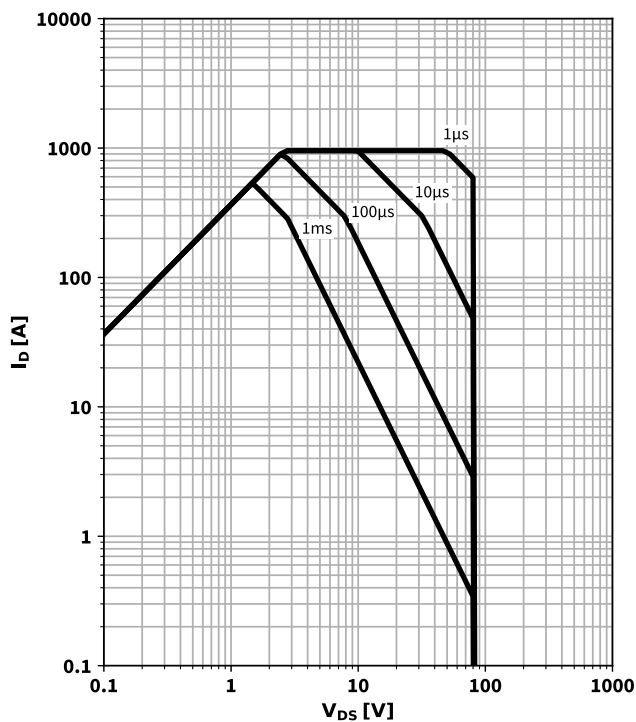
### 2 Drain current

$$I_D = f(T_C); V_{\text{GS}} \geq 6 \text{ V}$$



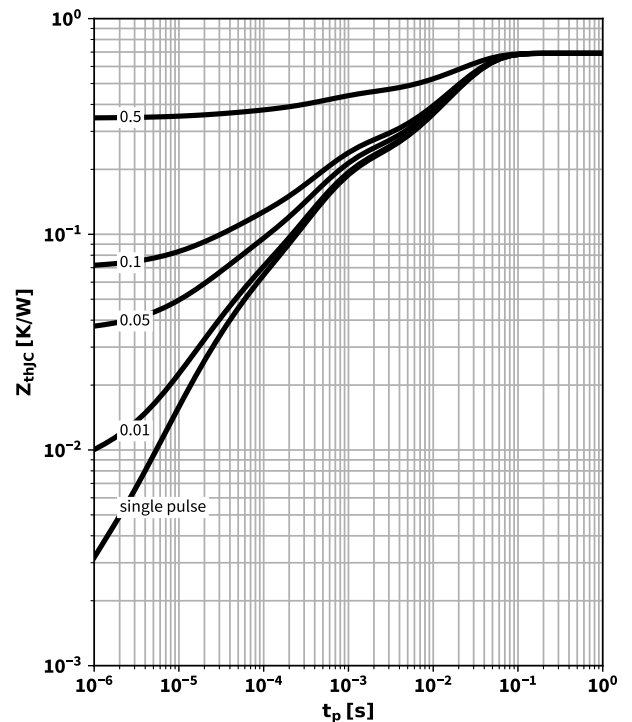
### 3 Safe operating area

$$I_D = f(V_{\text{DS}}); T_C = 25 \text{ °C}; D = 0; \text{ parameter: } t_p$$



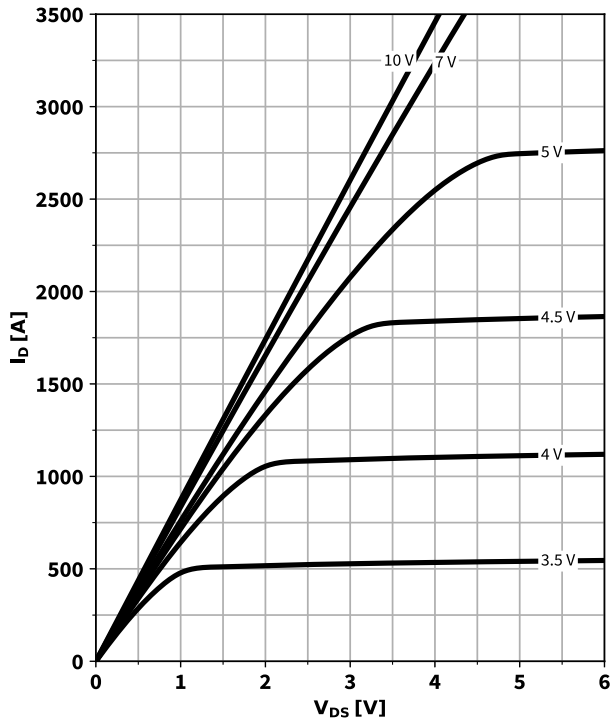
### 4 Max. transient thermal impedance

$$Z_{\text{thJC}} = f(t_p); \text{ parameter: } D = t_p/T$$



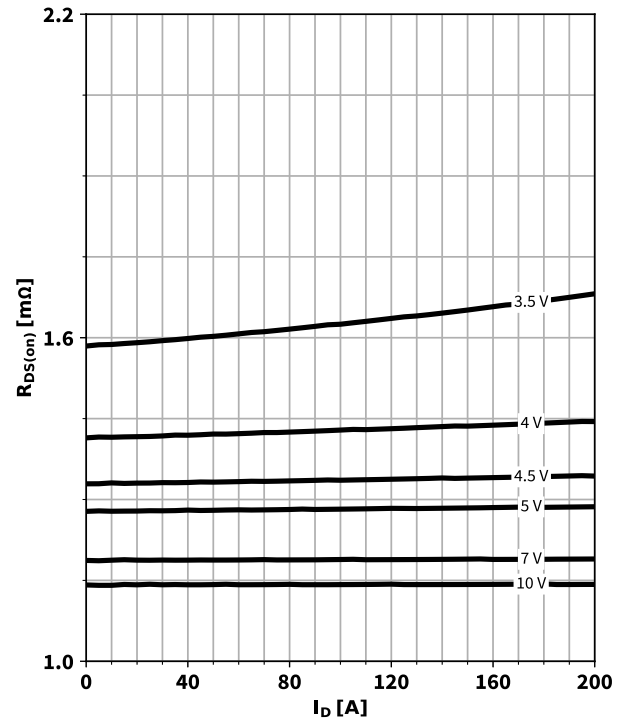
## 5 Typ. output characteristics

$I_D = f(V_{DS})$ ;  $T_j = 25^\circ\text{C}$ ; parameter:  $V_{GS}$



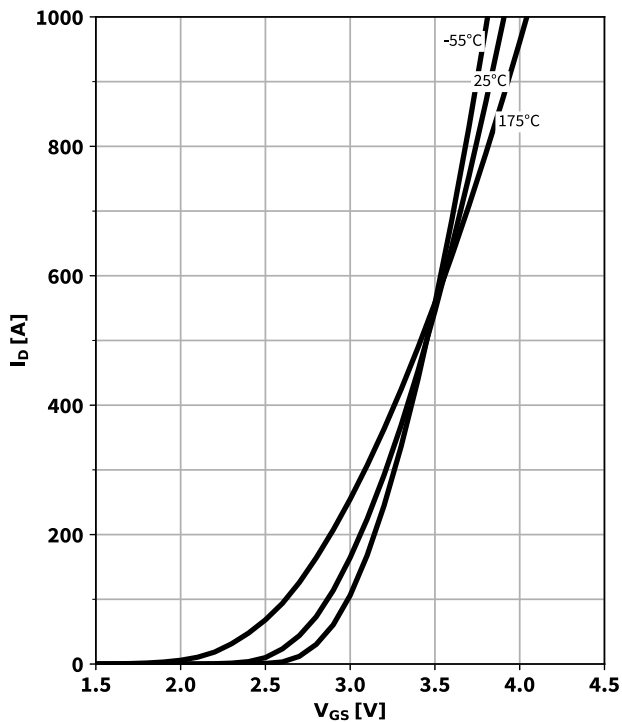
## 6 Typ. drain-source on-state resistance

$R_{DS(on)} = f(I_D)$ ;  $T_j = 25^\circ\text{C}$ ; parameter:  $V_{GS}$



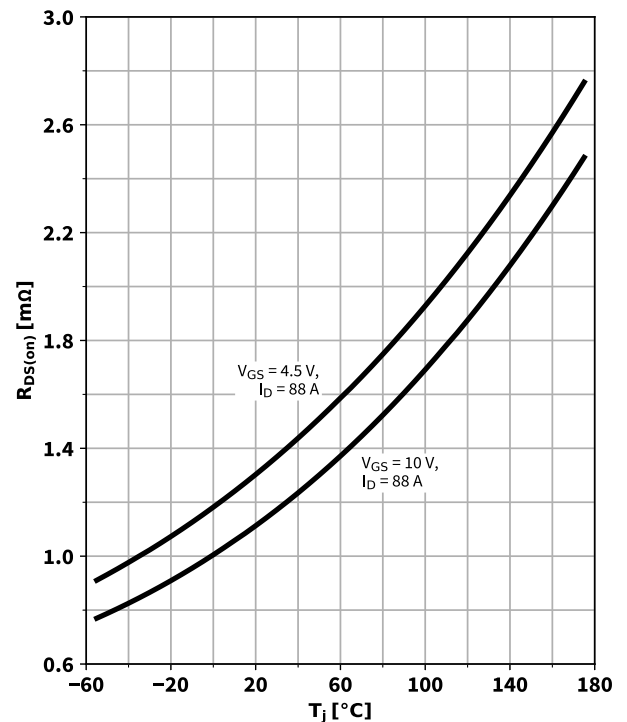
## 7 Typ. transfer characteristics

$I_D = f(V_{GS})$ ;  $V_{DS} = 6\text{ V}$ ; parameter:  $T_j$



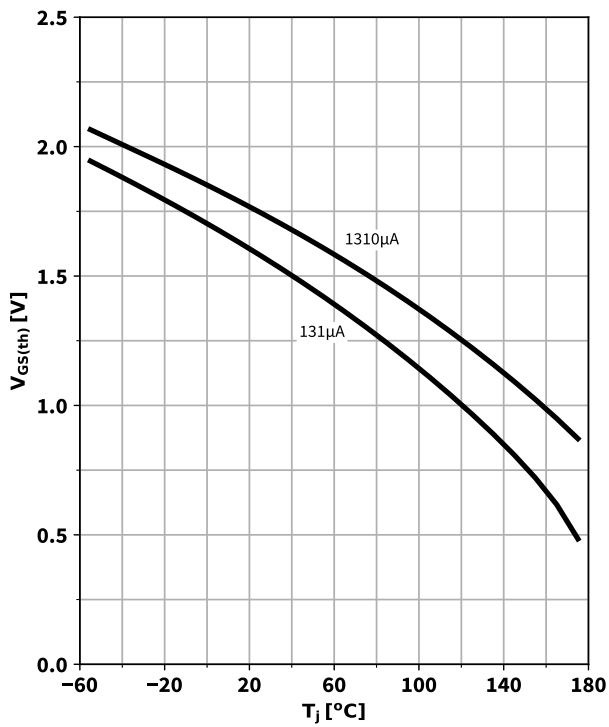
## 8 Typ. drain-source on-state resistance

$R_{DS(on)} = f(T_j)$ ; parameter:  $I_D$ ,  $V_{GS}$



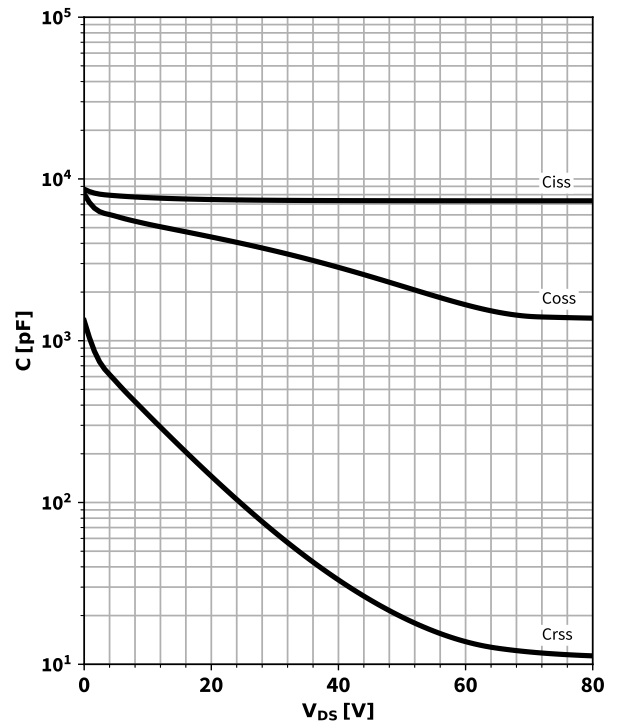
## 9 Typ. gate threshold voltage

$V_{GS(th)} = f(T_j)$ ;  $V_{GS} = V_{DS}$ ; parameter:  $I_D$



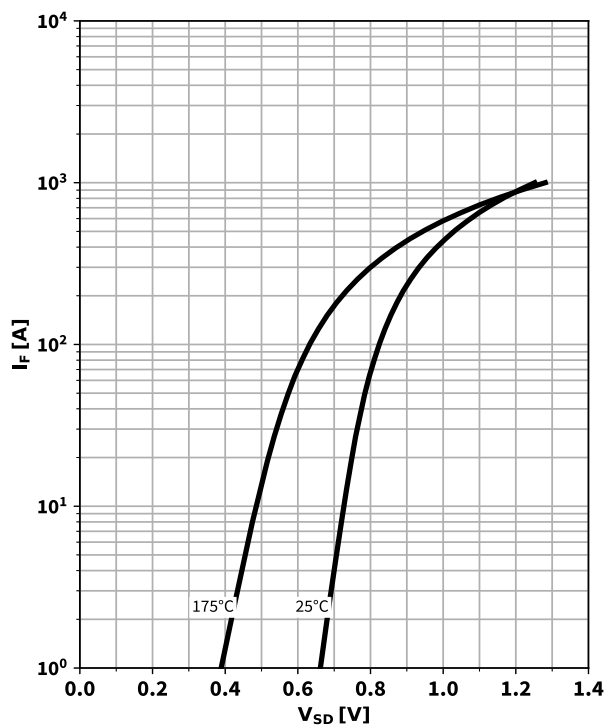
## 10 Typ. capacitances

$C = f(V_{DS})$ ;  $V_{GS} = 0 V$ ;  $f = 1 MHz$



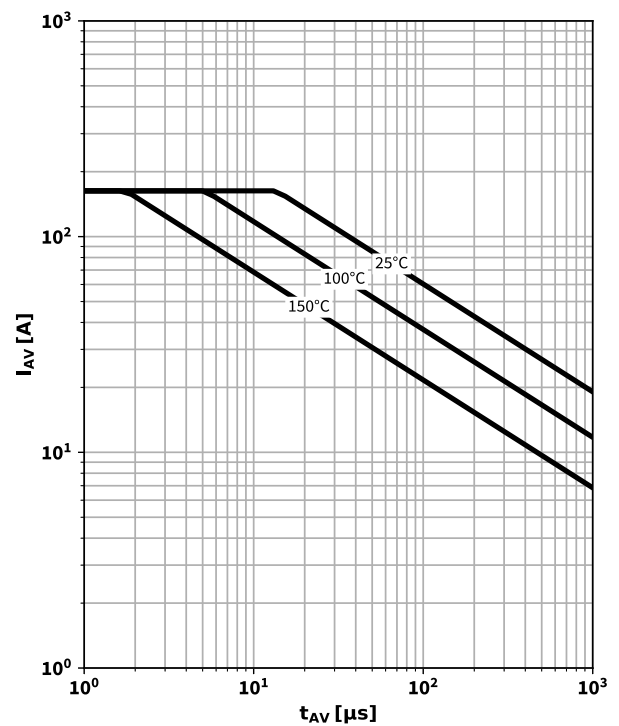
## 11 Typ. forward diode characteristics

$I_F = f(V_{SD})$ ; parameter:  $T_j$



## 12 Typ. avalanche characteristics

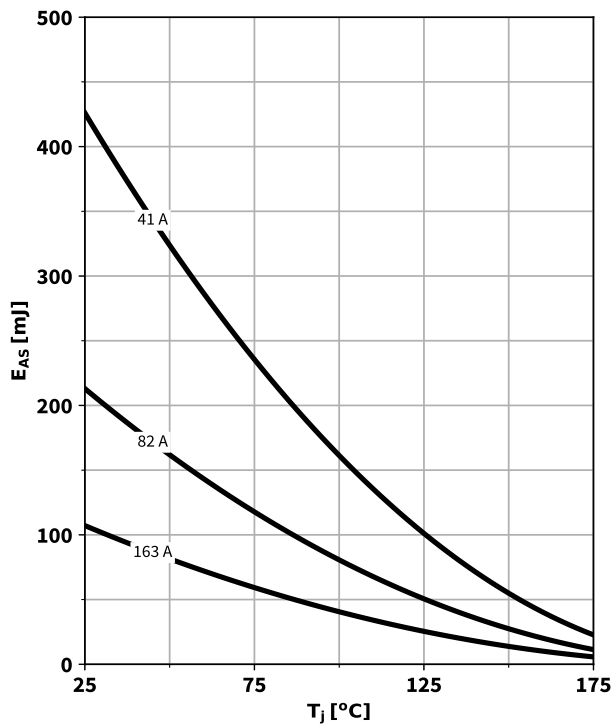
$I_{AS} = f(t_{AV})$ ; parameter:  $T_{j(start)}$





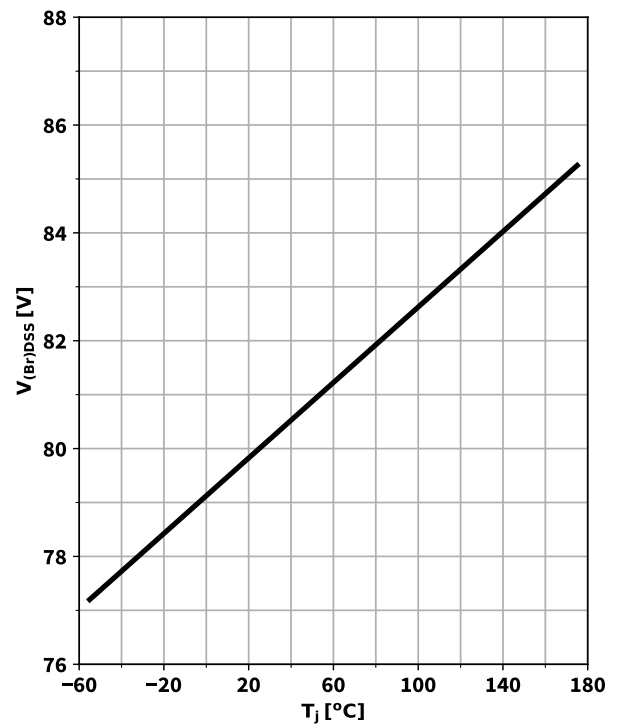
## 13 Typical avalanche energy

$E_{AS} = f(T_j)$ ; parameter:  $I_D$



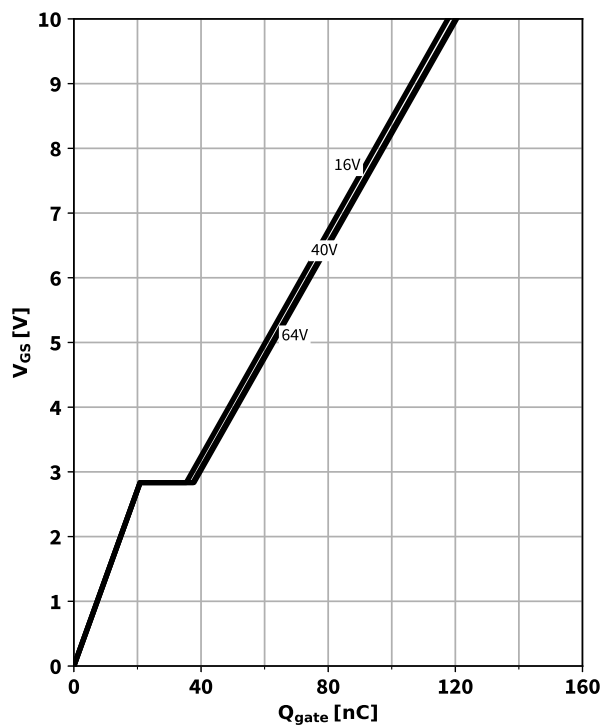
## 14 Drain-source breakdown voltage

$V_{(BR)DSS} = f(T_j)$ ;  $I_D = 1$  mA



## 15 Typ. gate charge

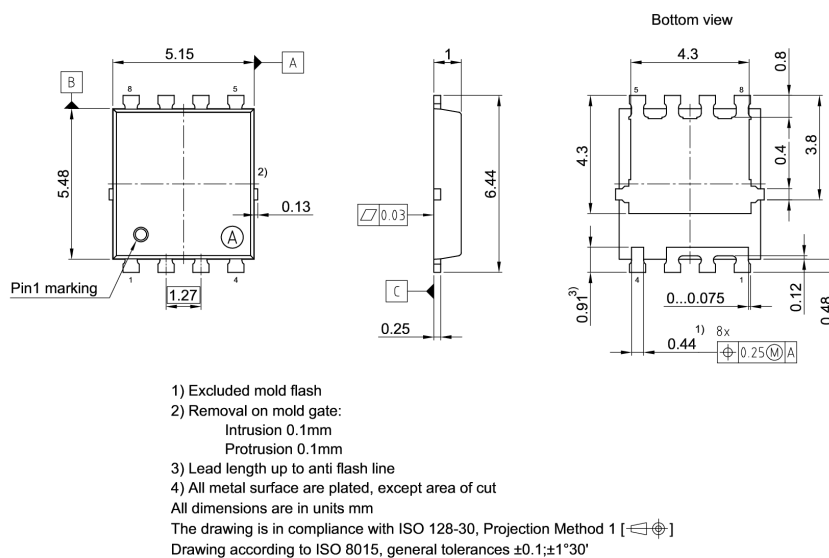
$V_{GS} = f(Q_{gate})$ ;  $I_D = 88$  A pulsed; parameter:  $V_{DD}$



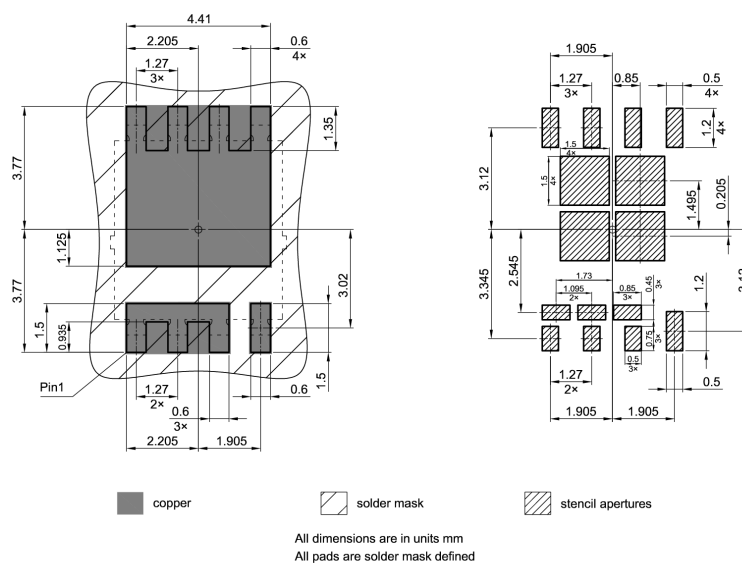
## 16 Gate charge waveforms



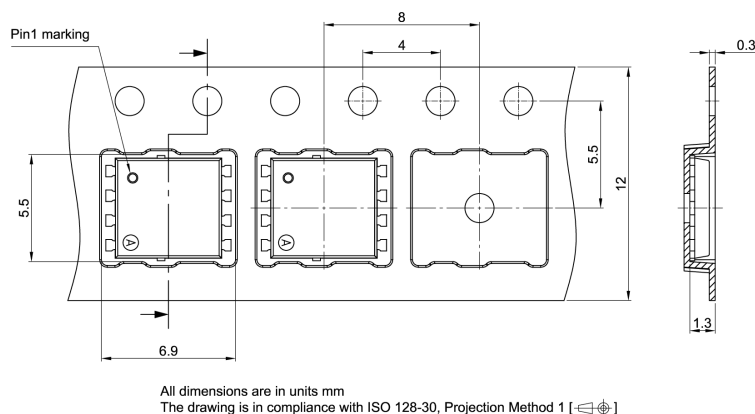
## Package Outline



## Footprint



## Packaging



## Revision History

Revision	Date	Changes
Revision 1.0	2025-04-02	Final data sheet

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**Email: [erratum@infineon.com](mailto:erratum@infineon.com)**

**Document reference**

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